

# United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/764,036 01/23/2004		David M. Pepper	B-3915 617817-8 7963			
36716	7590	03/10/2006		EXAMINER		
LADAS &		JLEVARD, SUITE	TURNER, SAMUEL A			
		90036-5679	ART UNIT	PAPER NUMBER		

2877
DATE MAILED: 03/10/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

			Application No.		Applicant(s)				
		10/764,03	6	PEPPER, DAVID	M.	16			
	Office Action Summary	Examiner		Art Unit		+			
		Samuel A.	Turner	2877					
Period fo	The MAILING DATE of this communic	cation appears on the	cover sheet with the c	orrespondence ad	Idress				
A SHO WHIC - Exter after: - If NO - Failur Any r	ORTENED STATUTORY PERIOD FOR HEVER IS LONGER, FROM THE MASSIONS OF time may be available under the provisions of SIX (6) MONTHS from the mailing date of this community period for reply is specified above, the maximum state to reply within the set or extended period for reply epply received by the Office later than three months afted patent term adjustment. See 37 CFR 1.704(b).	AILING DATE OF TH of 37 CFR 1.136(a). In no even unication. tutory period will apply and wi vill, by statute, cause the apply	IIS COMMUNICATION ent, however, may a reply be time Il expire SIX (6) MONTHS from ication to become ABANDONEI	I. lely filed the mailing date of this c (35 U.S.C. § 133).					
Status									
2a) ☐ 3) ☐	Responsive to communication(s) filed This action is <b>FINAL</b> . 2 Since this application is in condition followed in accordance with the practice.	b)⊠ This action is n or allowance except	on-final. for formal matters, pro		e merits is				
Dispositi	on of Claims								
5)	Claim(s) 1-36 is/are pending in the application (s) 1-36 is/are pending in the application (s) 1-36 is/are allowed.  Claim(s) 1-36 is/are rejected.  Claim(s) is/are objected to.  Claim(s) are subject to restrict on Papers  The specification is objected to by the The drawing(s) filed on is/are:  Applicant may not request that any objected to on the oath or declaration is objected to including the oath or declaration is objected to	e withdrawn from contion and/or election relation and/or election relation and/or election relation and/or election relation to the drawing(s) but the correction is require	equirement.  objected to by the E held in abeyance. See led if the drawing(s) is objections.	e 37 CFR 1.85(a). ected to. See 37 C					
Priority II	inder 35 U.S.C. § 119								
12) <u></u> a)[	<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority documents have been received.</li> <li>2. Certified copies of the priority documents have been received in Application No.</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>								
2) Notic 3) Inform	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (P mation Disclosure Statement(s) (PTO-1449 or I r No(s)/Mail Date 1/23/04.		4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other:	ate	O-152)				

#### DETAILED ACTION

## Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 1-18, 23, 25-27, 29, and 31-36 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

With regard to claims 1, 10, 25, and 34; the phrase "at least one beam between the first beam and the second beam" is confusing in that there appears to be a third beam claimed, the "at least one beam". The phrase "at least one of the first and the second beams" would definitely claim modulating one of the first and second beams.

With regard to claim 9, the phrase "at least one frequency between the first frequency, the second frequency and the modulator frequency is a tunable frequency" is confusing in that there appears to be a fourth frequency claimed, the "at least one frequency". The phrase "at least one of the first frequency, the second frequency, and the modulator frequency is a tunable frequency" would definitely claim that at least one of the frequencies is tunable.

With regard to claims 14, 23, 26, 29, and 35; the phrase "a sample whose spectral properties have to be detected" is confusing. Why does the samples a

spectral properties have to be detected? Does this distinguish from a sample whose spectral properties are to be detected?

With regard to claim 31, the phrase "an intermediate frequency inferior to the first frequency and the second frequency" is indefinite. What is "inferior" about the intermediate frequency? Is this a difference frequency or a beat frequency or some other frequency?

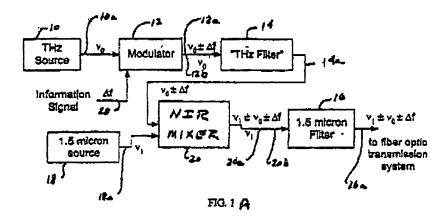
### Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1·3, 6·8, 10, 15·19, 24, 25, 27, 28, 30, and 34 are rejected under 35 U.S.C. 102(b) as being clearly anticipated by Mueller et al(2002/0036814). The rejected claims are not limited to any spectral measurement.



Art Unit: 2877

With regard to claim 1, Mueller et al teach an apparatus comprising:

a first laser, emitting a first beam having a first frequency(10, paragraph [0023]);

a second laser, emitting a second beam having a second frequency (18, paragraph [0019]), the difference between the first frequency and the second frequency being in a Terahertz range (paragraphs [0019] and [0023]);

a mixer, located downstream of the first laser and the second laser, the mixer producing a mixed signal (20, paragraph [0019]); and

a modulator modulating at least one beam between the first beam and the second beam(12, paragraph [0024]).

As to claim 2, wherein the mixed signal has a frequency spectrum comprising a carrier component and at least two sideband components, the carrier component centered at a Terahertz frequency(v<sub>1</sub>±v<sub>0</sub>±Δf).

As to claim 3, wherein the carrier component has a frequency displacement from the sideband components depending on the modulation of the at least one beam( $v_1\pm v_0\pm\Delta f$ ).

As to claim 6, wherein the modulator is located upstream of the mixer(figure 1).

As to claim 7, wherein the modulator performs frequency modulation of the at least one beam (at  $\Delta f$ ).

Art Unit: 2877

As to claim 8, wherein the modulator performs amplitude modulation of the at least one beam(12, paragraph [0024]).

With regard to claim 10, Mueller et al teach an apparatus comprising:

a first laser, emitting a first beam having a first frequency(10, paragraph
[0023]);

a second laser, emitting a second beam having a second frequency (18, paragraph [0019]), the difference between the first frequency and the second frequency being in a Terahertz range (paragraphs [0019] and [0023]);

a frequency modulator, having a modulation frequency, for frequency modulating one beam between the first beam and the second beam(12, paragraph [0024]); and

a mixer, having as an input the frequency modulated one beam and the other beam and outputting a mixed signal (20, paragraph [0019]).

As to claim 15, wherein the mixed signal has a frequency spectrum comprising sidebands, the sidebands comprising information to be transmitted to a remote location  $(v_1 \pm v_0 \pm \Delta f)$ .

As to claim 16, wherein the first laser and the second laser are narrowband lasers(paragraphs [0019] and [0023]).

As to claim 17, wherein the first laser and the second laser have a frequency band in a range of about 1 KHz to about 10 MHz(paragraphs [0019] and [0023], typical with narrow band lasers).

Art Unit: 2877

As to claim 18, wherein the first laser and the second laser are chosen from a group comprising laser diodes, fiber lasers, and diode-pumped solid state lasers(paragraphs [0023] and [0048]).

With regard to claim 19, Mueller et al teach an apparatus comprising:

a first laser, emitting a first beam having a first frequency(18, paragraph
[0019]);

a second laser, emitting a second frequency modulated beam having a carrier frequency and a modulation frequency(10,12; paragraph [0019]), the difference between the first frequency and the carrier frequency being in a Terahertz range(paragraphs [0019] and [0023]); and

a mixer, having as an input the first beam and the second frequency modulated beam and outputting a mixed signal (20, paragraph [0019]).

As to claim 24, wherein the mixed signal has a frequency spectrum comprising sidebands, the sidebands comprising information to be transmitted to a remote location  $(v_1 \pm v_0 \pm \Delta f)$ .

With regard to claim 25, Mueller et al teach an apparatus comprising:

a first laser, emitting a first beam having a first frequency(10, paragraph
[0023]);

a second laser, emitting a second beam having a second frequency (18, paragraph [0019]), the difference between the first frequency and the second frequency being in a Terahertz range (paragraphs [0019] and [0023]);

Art Unit: 2877

a modulator, for modulating in amplitude one beam between the first beam and the second beam(12, paragraph [0024]); and

a mixer, having as an input the amplitude modulated one beam and the other beam and outputting a mixed signal (20, paragraph [0019]).

As to claim 27, wherein the mixed signal has a frequency spectrum comprising sidebands, the sidebands comprising information to be transmitted to a remote location  $(v_1 \pm v_0 \pm \Delta f)$ .

With regard to claim 28, Mueller et al teach an apparatus comprising:

a first laser, emitting a first beam having a first frequency(18, paragraph [0019]);

a second laser, emitting a second amplitude modulated beam having a carrier frequency(10,12; paragraph [0019]), the difference between the first frequency and the carrier frequency being in a Terahertz domain(paragraphs [0019] and [0023]); and

a mixer, having as an input the first beam and the second amplitude modulated beam and outputting a mixed signal (20, paragraph [0019]).

As to claim 30, wherein the mixed signal has a frequency spectrum comprising sidebands, the sidebands comprising information to be transmitted to a remote location  $(v_1 \pm v_0 \pm \Delta f)$ .

With regard to claim 34, Mueller et al teach a method comprising: providing a first laser beam having a first frequency(10, paragraph [0023]);

Art Unit: 2877

providing a second laser beam having a second frequency(18, paragraph [0019]), the difference between the first frequency and the second frequency being a Terahertz frequency(paragraphs [0019] and [0023]);

modulating at least one beam between the first beam and the second beam(12, paragraph [0024]); and

mixing the first beam and the second beam to generate a mixed signal (20, paragraph [0019]).

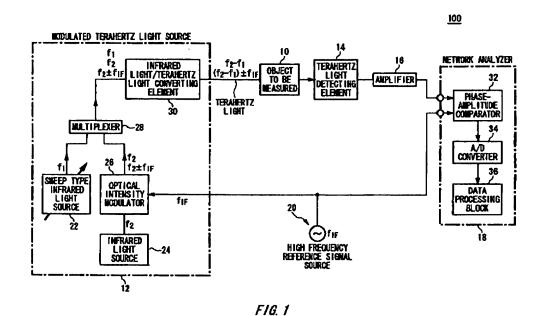
# Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-3, 6-30, and 34-36 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kido et al(6,873,405).

Art Unit: 2877



100 14b TERAHERTZ LIGHT DETECTING AND FREQUENCY CONVERTING ELEMENT 10 16 NETWORK ANALYZER INFRARED LIGHT/TERAHERTZ LIGHT CONVERTING OBJECT TO BE MEASURED AMPLIFIER ELEMENT PHASE-AMPLITUDE COMPARATOR TERAHERTZ LIGHT MULTIPLEXER ~28 A/D Converter MULTIPLEXER DATA PROCESSING 1-TH O-TH BLOCK DEMULTIPLEXER AON 42 18 SNEEP TYPE INFRARED LIGHT SOURCE INFRARED LIGHT SOURCE

F1G. 6

24

22

**∼**)fıғ HIGH FREQUENCY REFERENCE SIGNAL SOURCE

Art Unit: 2877

With regard to claim 1, Kido et al teach an apparatus comprising:

a first source, emitting a first beam having a first frequency(22, column 8, lines 66+);

a second source, emitting a second beam having a second frequency, the difference between the first frequency and the second frequency being in a Terahertz range(24, column 9, lines 7-15);

a mixer, located downstream of the first laser and the second laser, the mixer producing a mixed signal (28, column 9, lines 34-56); and

a modulator modulating at least one beam between the first beam and the second beam (26, column 9, lines 16-27).

While Kido refers to laser sources in the prior art, Kido is silent about the type of sources used in the disclosed embodiments.

As to claim 2, wherein the mixed signal has a frequency spectrum comprising a carrier component and at least two sideband components, the carrier component centered at a Terahertz frequency((f<sub>2</sub>-f<sub>1</sub>)±f<sub>IF</sub>).

As to claim 3, wherein the carrier component has a frequency displacement from the sideband components depending on the modulation of the at least one beam( $(f_2-f_1)\pm f_{IF}$ ).

As to claim 6, wherein the modulator is located upstream of the mixer (26,28; figure 1).

Art Unit: 2877

As to claim 7, wherein the modulator performs frequency modulation of the at least one beam (48; column 16, lines 64+).

As to claim 8, wherein the modulator performs amplitude modulation of the at least one beam (26, column 9, lines 16-27).

As to claim 9, wherein at least one frequency between the first frequency, the second frequency and the modulator frequency is a tunable frequency(22, column 8, lines 66+).

With regard to claim 10, Kido et al teach an apparatus comprising:

a first source, emitting a first beam having a first frequency(22, column 8, lines 66+);

a second source, emitting a second beam having a second frequency, the difference between the first frequency and the second frequency being in a Terahertz range(24, column 9, lines 7-15);

a frequency modulator, having a modulation frequency, for frequency modulating one beam between the first beam and the second beam(48; column 16, lines 64+); and

a mixer, having as an input the frequency modulated one beam and the other beam and outputting a mixed signal (28, column 9, lines 34-56).

While Kido refers to laser sources in the prior art, Kido is silent about the type of sources used in the disclosed embodiments.

As to claim 11, wherein the mixed signal is tunable (22, column 8, lines 66+).

As to claim 13, wherein the mixed signal is tunable by tuning the difference between the first frequency and the second frequency (22, column 8, lines 66+).

As to claim 14, wherein:

the mixed signal is adapted to be input to a sample whose spectral properties have to be detected (10, column 8, lines 34-41); and

the apparatus further comprises a detector, disposed downstream of the sample, for detecting a signal output from the sample in response to the mixed signal input thereto(14, column 10, lines 20-33).

As to claim 15, wherein the mixed signal has a frequency spectrum comprising sidebands, the sidebands comprising information to be transmitted to a remote location ( $(f_2-f_1)\pm f_{IF}$ ).

With regard to claim 19, Kido et al teach an apparatus comprising:

a first source, emitting a first beam having a first frequency(22, column 8, lines 66+);

a second source, emitting a second frequency modulated beam having a carrier frequency and a modulation frequency, the difference between the first frequency and the carrier frequency being in a Terahertz range(24, 48; column 9, lines 7-15 and column 16, lines 64+); and

a mixer, having as an input the first beam and the second frequency modulated beam and outputting a mixed signal (28, column 9, lines 34-56).

While Kido refers to laser sources in the prior art, Kido is silent about the type of sources used in the disclosed embodiments.

As to claim 20, wherein the mixed signal is tunable (22, column 8, lines 66+).

As to claim 22, wherein the mixed signal is tunable by tuning the difference between the first frequency and the second frequency (22, column 8, lines 66+).

As to claim 23, wherein:

the mixed signal is adapted to be input to a sample whose spectral properties have to be detected (10, column 8, lines 34-41); and

the apparatus further comprises a detector, disposed downstream of the sample, for detecting a signal output from the sample in response to the mixed signal input thereto(14, column 10, lines 20-33).

As to claim 24, wherein the mixed signal has a frequency spectrum comprising sidebands, the sidebands comprising information to be transmitted to a remote location ( $(f_2-f_1)\pm f_{IF}$ ).

With regard to claim 25, Kido et al teach an apparatus comprising:
a first source, emitting a first beam having a first frequency(22, column 8,

lines 66+);

a second source, emitting a second beam having a second frequency, the difference between the first frequency and the second frequency being in a Terahertz range(24, column 9, lines 7-15);

a modulator, for modulating in amplitude one beam between the first beam and the second beam(26, column 9, lines 16-27); and

a mixer, having as an input the amplitude modulated one beam and the other beam and outputting a mixed signal (28, column 9, lines 34-56).

While Kido refers to laser sources in the prior art, Kido is silent about the type of sources used in the disclosed embodiments.

As to claim 26, wherein:

the mixed signal is adapted to be input to a sample whose spectral properties have to be detected (10, column 8, lines 34-41); and

the apparatus further comprises a detector, disposed downstream of the sample, for detecting a signal output from the sample in response to the mixed signal input thereto(14, column 10, lines 20-33).

As to claim 27, wherein the mixed signal has a frequency spectrum comprising sidebands, the sidebands comprising information to be transmitted to a remote location ( $(f_2-f_1)\pm f_{IF}$ ).

With regard to claim 28, Kido et al teach an apparatus comprising:

a first source, emitting a first beam having a first frequency(22, column 8, lines 66+);

a second laser, emitting a second amplitude modulated beam having a carrier frequency, the difference between the first frequency and the carrier frequency being in a Terahertz domain(24,26; column 9, lines 7-27); and

Art Unit: 2877

a mixer, having as an input the first beam and the second amplitude modulated beam and outputting a mixed signal (28, column 9, lines 34-56).

While Kido refers to laser sources in the prior art, Kido is silent about the type of sources used in the disclosed embodiments.

As to claim 29, wherein:

the mixed signal is adapted to be input to a sample whose spectral properties have to be detected (10, column 8, lines 34-41); and

the apparatus further comprises a detector, disposed downstream of the sample, for detecting a signal output from the sample in response to the mixed signal input thereto(14, column 10, lines 20-33).

As to claim 30, wherein the mixed signal has a frequency spectrum comprising sidebands, the sidebands comprising information to be transmitted to a remote location ( $(f_2-f_1)\pm f_{IF}$ ).

With regard to claim 30, Kido et al teach a method comprising:

providing a first source beam having a first frequency(22, column 8, lines
66+);

providing a second laser beam having a second frequency, the difference between the first frequency and the second frequency being a Terahertz frequency(24, column 9, lines 7-15);

modulating at least one beam between the first beam and the second beam (26, column 9, lines 16-27); and

Art Unit: 2877

mixing the first beam and the second beam to generate a mixed signal (28, column 9, lines 34-56).

While Kido refers to laser sources in the prior art, Kido is silent about the type of sources used in the disclosed embodiments.

As to claim 35, further comprising:

inputting the mixed signal to a sample whose spectral properties have to be detected(10, column 8, lines 34-41); and

detecting a signal output from the sample in response to the mixed signal input thereto(14, column 10, lines 20-33).

As to claim 36, wherein inputting the mixed signal to a sample comprises tuning the mixed signal to create resonance with the spectral properties of the sample(22, column 10, lines 13-18).

Kido et al teach that the prior art, figures 9-11, uses a laser source(110,210,310) for measuring propagation, dispersion, and tomographic imaging.

With specific regard to claims 1, 10, 19, 25, 28, and 34; it would have been obvious to one of ordinary skill in the art at the time the invention was made to use laser sources as the light sources of Kido because of there wavelength characteristics(column 11, lines 34-37).

As to claims 16·18, since laser sources have narrow bandwidths(claim 16) of about 1 KHz to about 10 MHz(claim 17) and include laser diodes, fiber lasers, and diode-

Art Unit: 2877

pumped solid state lasers(claim 18) it would have been obvious to one of ordinary skill in the art at the time the invention was made to use the laser sources with a linewidth as narrow as possible(column 11, lines 34-37) from any laser source which provides the desired frequency.

With regard to claims 12 and 21, Kido et al fail to teach wherein the mixed signal is tunable by tuning the modulation frequency of the frequency modulator.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the Kido apparatus by tuning the modulation frequency  $f_{IF}$  instead of the source frequency  $f_1$  because a) the high frequency source is easier to tune than a tunable source which is unstable and can drift, and b) the mixed frequency  $(f_2 \cdot f_1) \pm f_{IF}$  will still be tuned across the frequency range of the sample.

Claims 4 and 5 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kido et al(6,873,405) as applied to claims 1-3, 6-30, and 34-36 above, and further in view of Ali et al(IEEE-7/2000) and Mueller et al(2002/0036814).

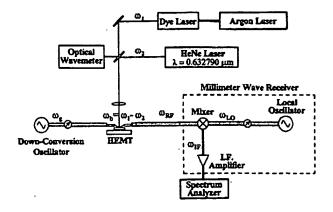


Fig. 1. Optical mixing arrangement in the three-wave detection configuration. The optically generated signals are downconverted in the HEMT's by injection of a millimeter-wave local oscillator signal to keep the resultant in the bandwidth of the external millimeter-wave receiver.

Art Unit: 2877

Ali et al teach a combination modulator/mixer arrangement including a first laser source  $\omega_1$ , and second laser source  $\omega_2$ , a lens, modulation signal  $\omega_g$ , and an HEMT. In Ali the difference frequency  $\omega_b$  is 552 GHz.

Mueller et al teach that HEMT's can operate in the terahertz range(paragraph [0019]).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to replace the modulator 26 and mixer 28 of Kido with a HEMT operating in the terahertz range in order to reduce the number of components.

Claims 31·33 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ali et al(IEEE·7/2000) and Mueller et al(2002/0036814).

With regard to claim 31, Ali et al teach an apparatus comprising:

a first laser, emitting a first beam having a first frequency(the argon and dye lasers,  $\omega_1$ );

a second laser, emitting a second beam having a second frequency(the HeNe laser,  $\omega_2$ );

a high electron mobility transistor (HEMT) having a first terminal, a second terminal, and a photoconductive region on which the first beam and the second beam impinge(the HEMT); and

a modulator having a modulation frequency (down-conversion oscillator,  $\omega_g$ ), for modulating an intermediate signal having an intermediate frequency inferior to the first frequency and the second frequency to obtain a modulated signal, the

Art Unit: 2877

modulated signal input to the first terminal of the HEMT, wherein the second terminal of the HEMT outputs a mixed signal having a frequency spectrum depending on the first frequency, the second frequency, the intermediate frequency, and the modulation frequency  $(\omega_1 - \omega_2 \pm \omega_g)$ .

Ali et al fail to teach a frequency difference in the terahertz range instead only reaching 552 GHz.

As to claim 32, further comprising an oscillator emitting the intermediate signal at the intermediate frequency (down-conversion oscillator,  $\omega_g$ ).

As to claim 33, further comprising an objective lens for focusing the first beam and the second beam on the photoconductive region of the HEMT(the lens, figure 1).

With regard to claim 31, it would have been obvious to one of ordinary skill in the art at the time the invention was made to increase the frequency difference into the terahertz range because of the advantages operating in the optical domain(Ali; column 1, page 879) since now HETM's can operate in the terahertz range (Mueller, paragraph [0019]).

#### Relevant Prior Art

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Bjorklund(4,297,035) and Oxley (IEEE-3/2002).

Art Unit: 2877

#### Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Samuel A. Turner whose phone number is 571-272-2432.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Gregory J. Toatley, Jr., can be reached on 571-272-2800 ext. 77.

The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <a href="http://pair-direct.uspto.gov">http://pair-direct.uspto.gov</a>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Samuel A. Turner Primary Examiner Art Unit 2877